

Search Notes

Application/Control No.

10/644,996

Examiner

Pierre-Louis Desir

Applicant(s)/Patent under
Reexamination

CHUN, CHANG-HYEN

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	442	7/31/2007	PD
455	436	7/31/2007	PD
455	522	7/31/2007	PD
455	434	7/31/2007	PD
370	352	7/31/2007	PD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	352	7/31/2007	PD
455	442	7/31/2007	PD
455	436	7/31/2007	PD
455/434,522		7/31/2007	PD

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	7/31/2007	PD